Seal	rcn notes
	18 81111 83131 13118 18118 1811 1381

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/660,899	RUHLEN, MATTHEW	
Examiner	Art Unit	
HUNG Q. PHAM	2168	

	SEARCHED				
 	JLAN	CHED	· · · · · · · · · · · · · · · · · · ·		
Class	Subclass	Date	Examiner		
707	2,10,104.1	10/19/2006	НР		
1	·		,		
J					
_					

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
1				

(INCLUDING SEARCH	STRATEGY)
	DATE	EXMR
EAST SEARCH	10/19/2006	HP
*	,	
	,	
·		
·		